

<b>Notice of References Cited</b>	Application/Control No. 10/791,269		Applicant(s)/Patent Under Reexamination CHUNG ET AL.	
	Examiner ROBERT HODGE		Art Unit 1729	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,994,926	02-2006	Ikeuchi et al.	429/7
*	B	US-2003/0165736	09-2003	Hiratsuka, Masaru	429/153
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	WO 01/99211 A1	12-2001	WIPO	Ikeuchi et al.	
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	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Definition of Substantially retrieved from Dictionary.com on 1-6-12
	V	Definition of Perpendicular retrieved from Dictionary.com on 1-6-12
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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